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Measuring Battery Quality

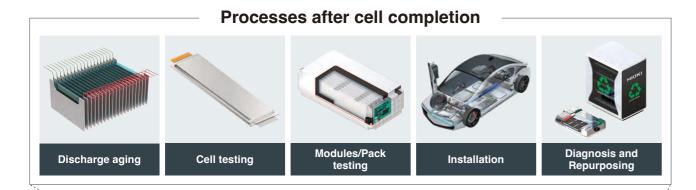
A variety of processes must be completed before a battery becomes a finished product and each process level requires an appropriate testing measurement method.

HIOKI battery testers are ideal for use in testing, development and inspections after cell completion.

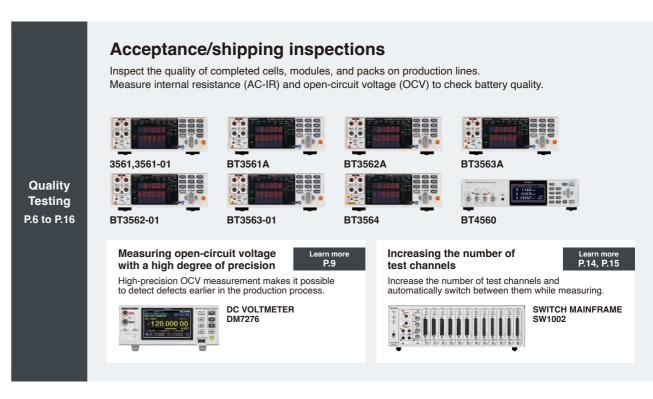




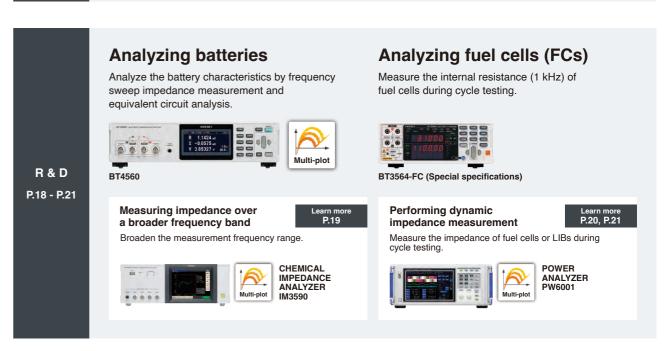












Battery tester lineup

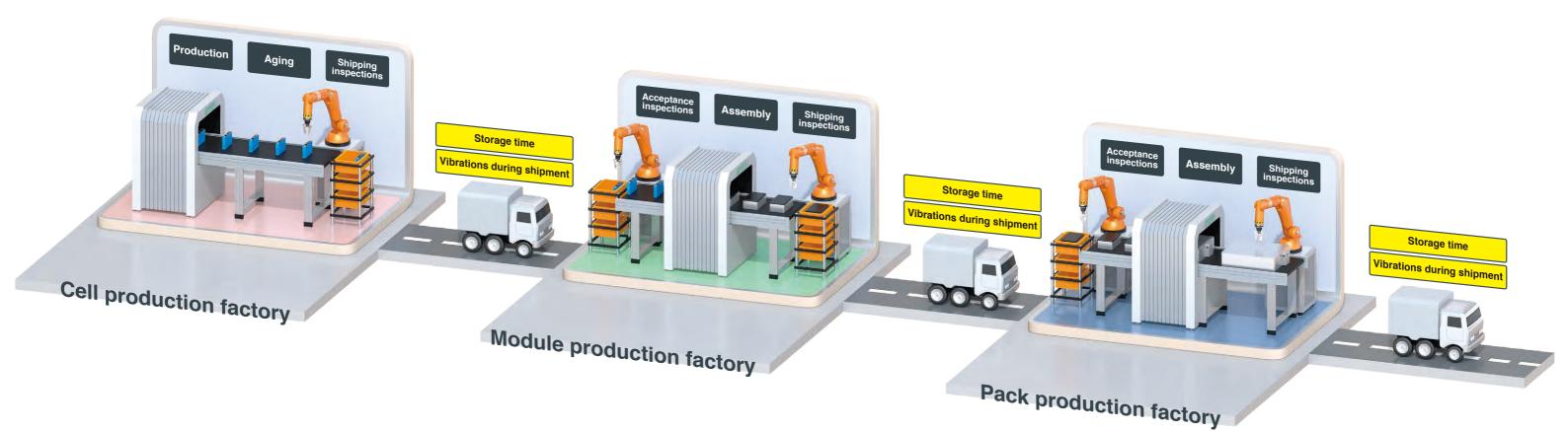
				Acceptance/ship	ping inspections		
Application			Small cells for general purpose High speed sorting	Small cells for power motors Small packs of up to 60 V	Large cells for xEVs Mid-sized packs of up to 100 V	Large packs for xEVs Large packs of up to 300 V	
Model		3561, 3561-01	BT3561A	BT3562A	BT3563A		
Appearance			3,1000	500,000	30000	30000	
Measurement method	t		AC four-terminal method	AC four-terminal method	AC four-terminal method	AC four-terminal method	
Measurement frequer	псу		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	
Rated input voltage			±22 V DC	±60 V DC	±100 V DC	±300 V DC	
Maximum rated voltage	ge to eart	h	±60 V DC	±60 V DC	±100 V DC	±300 V DC	
		3 mΩ	N/A	N/A	$3.1000~\text{m}\Omega,0.1~\mu\Omega,100~\text{m}A$	3.1000 m Ω , 0.1 $\mu\Omega$, 100 m	
Resistance measurement		30 mΩ	N/A	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 m/	
ranges		300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	
ω Max. display,		3Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA 31.000 Ω, 1 mΩ, 100 μA	3.1000 Ω,100 μΩ, 1 mA	
Max. display, resolution, measurement current		30 Ω 300 Ω	N/A N/A	31.000 Ω, 1 mΩ, 100 μA 310.00 Ω, 10 mΩ, 10 μA	31.000 Ω, 1 mΩ, 100 μA 310.00 Ω, 10 mΩ, 10 μA	31.000 Ω, 1 mΩ, 100 μA 310.00 Ω, 10 mΩ, 10 μA	
measurement		3 kΩ	N/A	3.1000 kΩ, 100 mΩ, 10 μΑ	3.1000 kΩ, 100 mΩ, 10 μΑ	3.1000 kΩ, 100 mΩ, 10 μλ	
	sic	3 mΩ	N/A	N/A	±0.5% rdg ±10 dgt	±0.5% rdg ±10 dgt	
=	curacy	range 30 mΩ	±0.5% rdg ±5 dgt	±0.5% rdg ±5 dgt	±0.5% rdg ±5 dgt	±0.5% rdg ±5 dgt	
<u> </u>		range or more	N/A	6.000 00 V,10 μV	6.000 00 V,10 μV	6.000 00 V, 10 μV	
Voltage	20 V		19.999 9 V, 100 μV	N/A	N/A	N/A	
		60 V	N/A	60.000 0 V, 100 μV	60.000 0 V, 100 μV	60.000 0 V, 100 μV	
ranges		100 V	N/A	N/A	100.000 V, 1 mV	N/A	
Max. display,		300 V	N/A	N/A	N/A	300.000 V, 1 mV	
resolution		1000 V	N/A	N/A	N/A	N/A	
Ba	sic accur	acy	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	
Response time *1			3 ms	10 ms	10 ms	10 ms	
Sampling period "2		Ω or V	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 n	
EX.FAST, FAST, MEDIUN	И, SLOW	ΩV	7 ms, 23 ms, 69 ms, 252 ms	8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 n	
Allowable total line resis error detection) Ranges: 3 mΩ, 30 mΩ, 300		SENSE line SOURCE line	N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω	N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω	
Open terminal voltage Ranges: 30 mΩ or less, 3	9		N/A, 7 V, 7 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	
LAN (TCP/IP, 10B			N/A	YES	YES	YES	
RS-232C *4 (Max.			YES	YES	YES	YES	
USB USB	00400 bp	(3)	N/A	N/A	N/A	N/A	
GP-IB			YES (3561-01 Only)	N/A	N/A	N/A	
EXT I/O (37-pin H	andler int	erface)	YES (36-pin)	YES	YES	YES	
Analog output (De	C 0 V to 3	3.1 V)	N/A	YES	YES	YES	
Contact check			YES	YES	YES	YES	
Zero adjustment (±1000 co	unts)	YES	YES	YES	YES	
Measurement curr	rent pulse	output	N/A	YES	YES	YES	
Comparator			Hi/ IN/ Lo	Hi/ IN/ Lo	Hi/ IN/ Lo	Hi/ IN/ Lo	
Statistical calculat	ions		Max. 30,000	Max. 30,000	Max. 30,000	Max. 30,000	
			YES	YES	YES	YES	
Average			2 to 16 times	2 to 16 times	2 to 16 times	2 to 16 times	
Panel saving/load	ıng		126	126	126	126	
Memory storage	5		400 YES	400 YES	400 YES	400 YES	
LabVIEW® driver '5 Applicable standards		Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A		
Effect of radiated radi	o-frequer	ncy	Resistant '6	Resistant '6	Resistant '6	Resistant '6	
Effect of conducted		10 V	N/A	Resistant	Resistant	Resistant	
radiofrequency electromagnetic field		3 V	Resistant	Resistant	Resistant	Resistant	
CE			YES	YES	YES	YES	
			N/A	YES	YES	YES	
CSA *7							

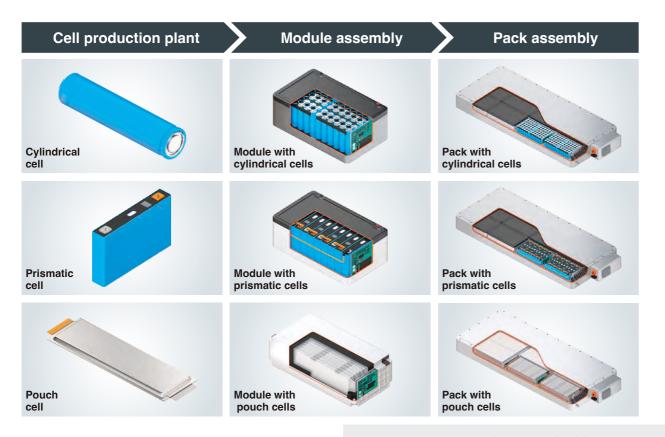
			Acceptance/ship	ping inspections	R & D	Maintenance	
Application			Extra large packs for xEV, ESS 1000 V high voltage model	GP-IB model	Cells or packs up to 20 V Degree of deterioration for reuse	Large-scale UPS	
Model		BT3564	BT3562-01 BT3563-01	BT4560	BT3554-50 ^{*10} BT3554-51 ^{*10} BT3554-52 ^{*10}		
Appearance			Special specifications for FCs available	31000 500000	Special specifications for 10 kHz available (Refer to P.19)	-:: -: -: -	
Measurement meth	ıod		AC four-terminal method	AC four-terminal method	AC four-terminal pair method	AC four-terminal metho	
Measurement frequ			1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	0.10 Hz to 1050 Hz	1 kHz ±80 Hz	
Rated input voltage	,		±1000 V DC	BT3562-01: ±70 V DC BT3563-01: ±300 V DC	±5 V DC Special specification supports up to ±20 V DC	±60 V DC	
Maximum rated volt	tage to eart	th	±1000 V DC	BT3562-01: ±60 V DC BT3563-01: ±300 V DC	SOURCE-H, SENSE-H: ±5 V DC SOURCE-L, SENSE-L: 0 V DC	±60 V DC	
		3 mΩ	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA	Resistance (R)		
Resistance measurement		30 mΩ	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	3.6000 mΩ, 0.1 μΩ, 1.5 A 12.0000 mΩ, 0.1 μΩ, 500 mA	Resistance (R)	
ranges		300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	120.000 mΩ, 1 μΩ, 50 mA	3.100 m Ω , 1 $\mu\Omega$, 160 m A 31.00 m Ω , 10 $\mu\Omega$, 160 m	
Maria di Sala		3 Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	[The number of waveforms] Frequency: FAST, MEDIUM, SLOW	310.0 m Ω , 100 $\mu\Omega$, 16 m	
Max. display, resolution.		30 Ω	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μΑ	0.10 Hz to 66 Hz: 1 wave, 2 waves, 8 waves	3.100 Ω , 1 m Ω , 1.6 mA [Basic accuracy]	
measurement		300 Ω	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μΑ	67 Hz to 250 Hz: 2 waves, 8 waves, 32 waves 260 Hz to 1050 Hz: 8 waves, 32 waves, 128 waves	±1.0% rdg ±8 dgt	
max. display, resolution, measurement current		3 kΩ	3.1000 kΩ, 100 mΩ, 10 μΑ	3.1000 kΩ, 100 mΩ, 10 μΑ	Reactance (X)	$(3 \text{ m}\Omega \text{ range})$ ±0.8% rdg ±6 dgt $(30 \text{ m}\Omega \text{ range or more})$	
	Basic	3 mΩ range 30 mΩ	±0.5% rdg ±10 dgt *8	±0.5% rdg ±10 dgt	± 3.6000 mΩ, 0.1 μ Ω, 1.5 A ± 12.0000 mΩ, 0.1 μ Ω, 500 mA		
Voltage measurement	accuracy	range or more	±0.5% rdg ±5 dgt *8	±0.5% rdg ±5 dgt	±120.000 mΩ, 1 μΩ, 50 mA		
	6 V		N/A	6.000 00 V, 10 μV	Impedance (Z) 3.6000 mΩ, 0.1 μΩ, 1.5 A	6.000 V, 1 mV	
Voltage measurement		10 V	9.999 99 V, 10 μV	N/A	12.0000 mΩ, 0.1 μΩ, 500 mA	60.00 V, 10 mV	
ranges		60 V 100 V	N/A	60.000 0 V, 100 μV N/A	120.000 mΩ, 1 μ Ω, 50 mA Phase angle (θ)	[Basic accuracy] ±0.08% rdg ±6 dgt	
		300 V	99.999 9 V, 100 μV N/A	300.000 V, 1 mV (BT3563-01 only)	±180.000°, 0.001°	T (%C)	
Max. display, resolution		1000 V	1100.00 V, 1 mV *9	N/A	[Basic accuracy] Refer to P.19 Voltage (V)	Temperature (°C) -10.0°C to 60.0°C, 0.1°C	
Basic accuracy		±0.01% rdg ±3 dgt *8	±0.01% rdg ±3 dgt	±5.10000 V, 10 μV			
Response time *1		700 ms	10 ms	[Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period]	1.6 s		
Sampling period "2		Q or V	N/A, 12 ms, 35 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms	FAST, MEDIUM, SLOW	N/A	
EX.FAST, FAST, MEDI	UM, SLOW	ΩV	N/A, 28 ms, 74 ms, 359 ms	8 ms, 24 ms, 70 ms, 253 ms	0.1 s, 0.4 s, 1.0 s Temperature (°C)	100 ms	
Allowable total line re	sistance "1 "3	SENSE line	3 Ω, 3 Ω, 20 Ω, 20 Ω	2 Ω, 2 Ω, 15 Ω, 15 Ω	-10.0°C to 60.0°C, 0.1°C	N/A	
error detection) Ranges: 3 mΩ, 30 mΩ, 30	00 mO 3 O	SOURCE line	3 Ω, 3 Ω, 20 Ω, 200 Ω	2 Ω, 2 Ω, 15 Ω, 150 Ω	Allowable total line resistance '1 '3 (error detection)	N/A	
Open terminal volta	ige		25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	3 m Ω , 10 m Ω , 100 m Ω SENSE line: 10 Ω , 15 Ω , 50 Ω SOURCE line: 1.5 Ω , 4 Ω , 45 Ω	5 V max	
LAN (TCP/IP, 10			N/A	N/A	N/A		
RS-232C *4 (Max			YES	YES	YES	USB Wireless communication	
	k. 00400 bp	15)	N/A	N/A	YES	(*when Z3210 installed)	
USB GP-IB			YES	YES	N/A		
EXT I/O (37-pin	Handler in	terface)	YES	YES	YES	 Memory function (Up to 6000 data) 	
EXT I/O (37-pin Handler interface)			YES	YES	N/A	Auto memory function	
	Analog output (DC 0 V to 3.1 V)			\/F0	YES	Auto-hold functionMeasurement Navigato	
	DC 0 V to 3		YES	YES	150		
Analog output (<u>'</u>		YES YES	YES	YES'11	(When using Z3210,	
Analog output (Contact check	t (±1000 co	ounts)	-	-	-		
Analog output (Contact check Zero adjustment Measurement co Comparator	t (±1000 co urrent pulse	ounts)	YES	YES	YES ''' YES Hi/ IN/ Lo	(When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off	
Analog output (Contact check Zero adjustment Measurement co Comparator	t (±1000 co urrent pulse	ounts)	YES YES Hi/ IN/ Lo Max. 30,000	YES YES Hi/ IN/ Lo Max. 30,000	YES '11 YES Hi/ IN/ Lo N/A	(When using Z3210, GENNECT Cross : Voice guide output)	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay	t (±1000 co urrent pulse	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES	YES YES Hi/ IN/ Lo Max. 30,000 YES	YES '11 YES Hi/ IN/ Lo N/A YES	(When using Z3210, GENNECT Cross: Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average	t (±1000 co urrent pulse lations	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa	t (±1000 co urrent pulse lations	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage	t (±1000 co urrent pulse lations	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive	t (±1000 co urrent pulse lations	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI Excel® Direct Input func	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive	t (±1000 co urrent pulse lations	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI Excel® Direct Input func (When using Z3210) Safety: EN61010 EMC: EN61326 Class	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive	t (±1000 co urrent pulse lations	ounts)	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI Excel® Direct Input func (When using Z3210)	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard effect of radiated radiectromagnetic fiel	t (±1000 co urrent pulse lations	nunts) e output ncy	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A	YES '11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI Excel® Direct Input func (When using Z3210) Safety: EN61010 EMC: EN61326 Class Resistant (3 V/m)	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated raelectromagnetic fiel Effect of conducted adiofrequency electromagnetic fiel	t (±1000 co urrent pulse lations	ounts) e output	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant	YES "11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant "6 N/A Resistant	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAll Excel® Direct Input func (When using Z3210) Safety: EN61010 EMC: EN61326 Class Resistant (3 V/m) N/A	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated raelectromagnetic fiel Effect of conducted adiofrequency electromagnetic fiel CE	t (±1000 co urrent pulse lations	nunts) e output ncy	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant YES	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant YES	YES "11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant "6 N/A Resistant YES	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAll Excel® Direct Input func (When using Z3210) Safety: EN61010 EMC: EN61326 Class Resistant (3 V/m) N/A N/A YES	
Analog output (Contact check Zero adjustment Measurement of Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated raelectromagnetic fiel Effect of conducted adiofrequency electromagnetic fiel	t (±1000 co urrent pulse lations	nunts) e output ncy	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant	YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant	YES "11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant "6 N/A Resistant	(When using Z3210, GENNECT Cross: Voice guide output) Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAI Excel® Direct Input func (When using Z3210) Safety: EN61010 EMC: EN61326 Class Resistant (3 V/m) N/A	

^{*1:} Typical value *2: When the power supply frequency is 60 Hz *3: Total line resistance = wiring resistance + contact resistance + DLIT resistance *4: Available as printer I/F *5: LabVIEW® Driver is a registered trademark of National Instruments Corporation *6: Tes *7: Canadian Standards Assosiation (ES) Equipments Scientifiques SA - L

^{*8.} Δuarage function: When set to ON 4 times *9. Resolution 10 mV for 1000 00 V or more *10: -50: Instrument only, -51: 9465-10 bundle, -52: L2020 bundle 3.000 mΩ (100 mΩ range), X: ±1.5000 mΩ (Common for all ranges), V: ±0.10000 V

Measuring battery performance and safety





Measuring battery performance and safety using internal resistance (AC-IR) and open-circuit voltage (OCV)

Testing plays an important role in production processes by allowing plants to manufacture safe, high-performance batteries. During shipping and acceptance inspections, technicians assess battery performance by measuring internal resistance and safety by measuring open-circuit voltage.

Our Battery testers meet these needs...

"We want to manufacture batteries with stable performance."

"We want to manufacture highly safe batteries."

Assembly process (from cell batteries to pack batteries)

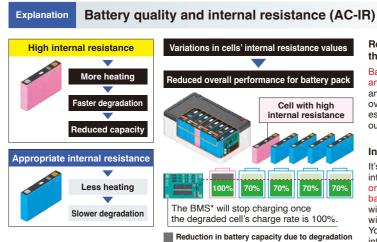
Cells produced at the cell production factory are shipped to the module production factory after undergoing a shipping inspection. Since factors such as vibrations during shipment and even the passage of time can cause defects, batteries undergo an acceptance inspection before being assembled into modules and packs.

Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Measuring battery performance and safety

Manufacturing batteries with stable performance



% Charging rate

Relationship between the internal resistance and the decline of battery cell capacity

Battery cells with high internal resistance tend to generate more heat and degrade faster. When cells degrade, their capacity declines, and their internal resistance rises. Internal resistance also changes over time or as a consequence of vibrations during shipment. It's essential to eliminate cells with high internal resistance by carrying out an inspection each time cells are shipped or received.

Internal resistance and battery pack performance

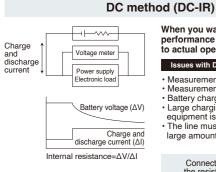
It's important that all the cells in a given battery pack have uniform internal resistance. If one or more cells have high internal resistance or have degraded, they will become a bottleneck and limit the battery pack's capacity. Moreover, the battery pack's performance will rapidly decline as the BMS* attempts to protect degraded cells with reduced capacity from overcharging and over-discharging. You can improve battery cell quality by selecting cells with uniform internal resistance so that they will degrade uniformity

AC method (AC-IR)

Internal resistance measurement (AC-IR measurement)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

There are two methods for measuring a battery's internal resistance: the AC method and the DC method. Resistance values are known as AC-IR when measured using the AC method, and as DC-IR when measured using the DC method. AC-IR and DC-IR have a complementary relationship, and it's recommended to choose the one that best suits your application, or to carry out both measurements. HIOKI battery testers can perform 4-terminal AC-IR measurement.



*BMS: Battery Management System

resistance

When you want to check battery performance under conditions close to actual operation Issues with DC-IR

 Measurement takes more time Measurements are less reproducible.

Battery capacity Amount of charge

- · Battery charges rate changes.
- · Large charging and discharging
- equipment is required.

 The line must be capable of supplying large amounts of power.

Connect a load and measure the resistance value based on the change in voltage and current.

AC voltage meter current source voltage Voltage

Vs=Internal resistance x Is

When you wish to identify defective products quickly and accurately, for example during shipping or acceptance inspections

- · Quickly measurement with milliseconds
- Measurements are highly reproducible. Battery charges rate not changes.
- · Testing can be carried out with compact equipment in an energy-saving manner

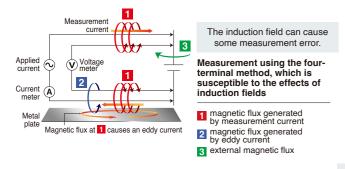
Apply the measurement current at a measurement frequency of 1 kHz and calculate the battery's internal resistance

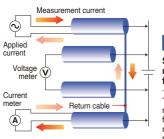
Two standards on LIB performance testing, IEC 61960-3/JIS C8711 (for compact equipment) and IEC 62620/JIS C8715-1 (for industrial equipment) describe how to measure internal resistance using the AC method (AC-IR). The method is also used in manufacturing processes for automotive LIB cells, which are required to deliver high levels of performance and safety.

Low-resistance measurement (1 mΩ and lower) for large batteries

BT4560

The larger the battery, the lower its internal resistance. Large batteries used in automobiles and infrastructure applications sometimes have internal resistance values of less than 1 mΩ. The BT4560's four-terminal-pair measurement method, which reduces the effects of induction fields, is an optimal solution for accurately measuring such low resistance levels.





BT4560

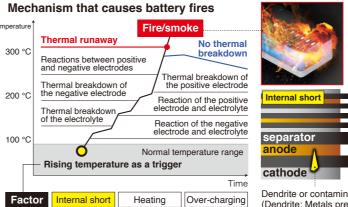
Stable, high-precision four-terminal-pair method

The effects of induction fields can be reduced by applying a current that measurement current in order to limit magnetic flux

Measuring battery performance and safety

Manufacturing highly safe batteries

Internal shorts and open-circuit voltage (OCV)



Insulation defects, which can be caused by factors such as ageing and vibrations during shipment, can lead to fire and other dangerous accidents, making it necessary to check open-circuit voltage values in order to distinguish between defective and non-defective products.

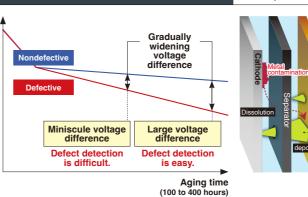
Open-circuit voltage (OCV)

The battery voltage when no load is connected is known as the opencircuit voltage (OCV). When an insulation defect such as an internal short occurs inside the battery, self-discharge causes the open-circuit voltage to decrease

Dendrite or contaminated metal (Dendrite: Metals precipitated dendritic form)

Open-circuit voltage (OCV)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276



Since the amount of change in OCV caused by self-discharge is extremely small, it is necessary to age batteries at least 100 to 400 hours before testing can accurately distinguish between non-defective and defective products. Additionally, it is necessary to measure OCV multiple times during the aging process. Using an instrument with good accuracy makes it possible to remove defects from the testing line earlier in the process, significantly reducing management and testing costs.

Dendrites form over time as minuscule metal fragment contaminants dissolve, leading to internal shorts.

High-accuracy OCV measurement

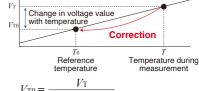
3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276

		Hi	gh-accuracy
Model	BT356x series	BT4560	DM7276 (DC VOLTMETER)
Appearance		0 0 0 0 1	120 000 00
Recommended range for 4 V measurement	6 V range	5 V range	10 V range
Number of digit, Max. Display	5 1/2 digit, 6.000 00	5 1/2 digit, 5.100 00	7 1/2 digit, 12.000 000
Resolution*1	10 μV	10 μV	1 μV
Basic accuracy*1	±0.01% rdg ±3 dgt	±0.0035% rdg ±5 dgt	±0.0009% rdg ±12 μV
Measurement error*1 *2	±430 μV	±190 μV	±48 μV
Period of accuracy guarantee	1 year	1 year	1 year
Temperature measurement	N/A	YES	YES
Temperature Compensation Function	N/A	N/A	YES

*1: When using recommended range for 4 V measurement *2: When measuring a 4 V LIB cell

OCV fluctuates with the ambient temperature

A battery's OCV value can fluctuate several hundred microvolts with a change of just 1°C in the ambient temperature. Temperature correction functionality allows the instrument to display a value that has been converted to the voltage at the reference temperature.



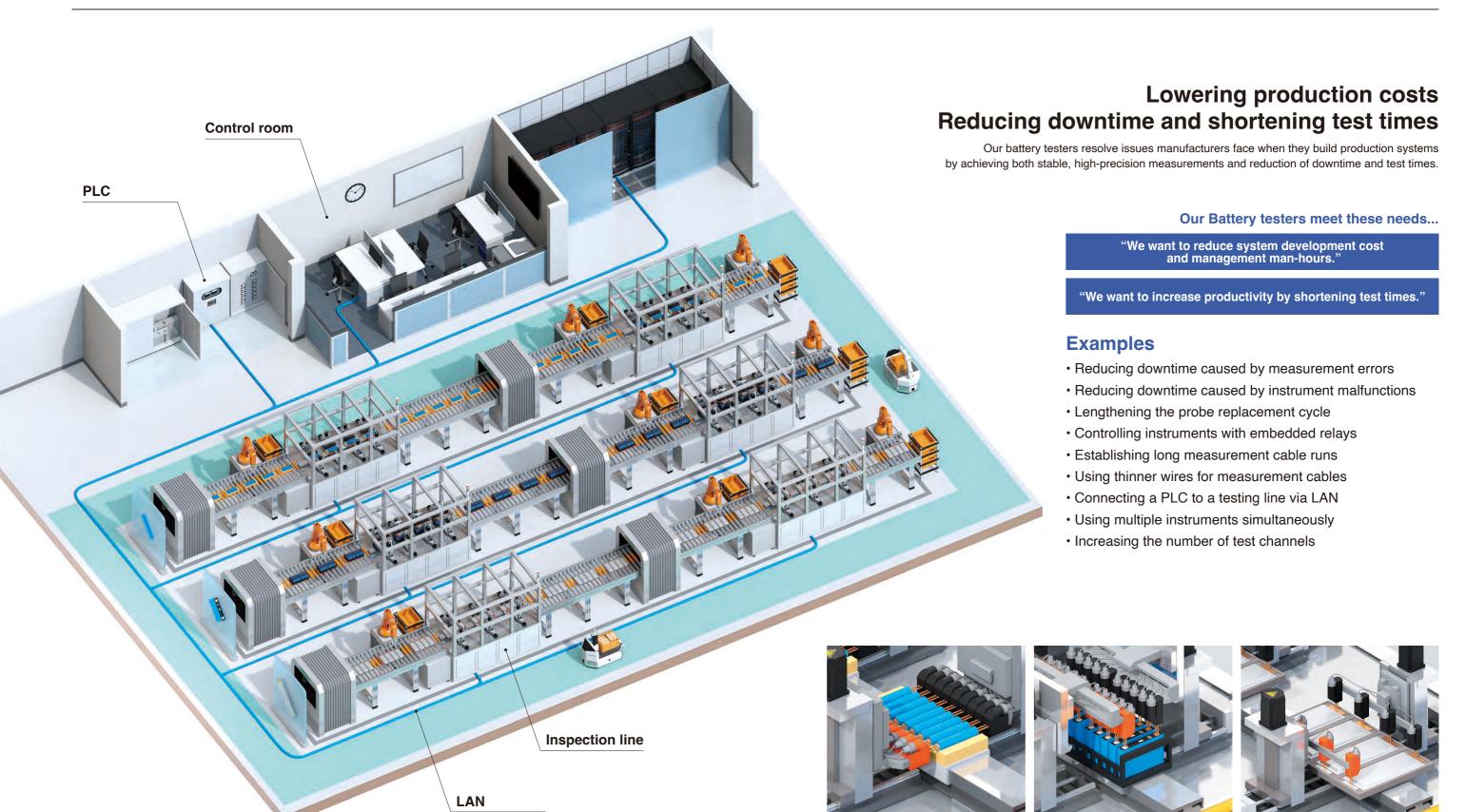
 $1 + \alpha_{T0} (T - T_0)$

: Measured voltage value [V]

V_{T0}: Voltage value after correction [V]

 α_{T0} : Temperature coefficient at T_0 [1/°C]

Integrate to automatic testing system



Testing of cylindrical cells

Testing of prismatic cells

Testing of pouch cells

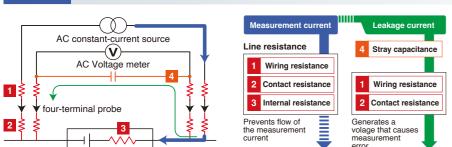
Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system

Reducing test system development cost and management man-hours

Line resistance and measurement current, line resistance and leakage current



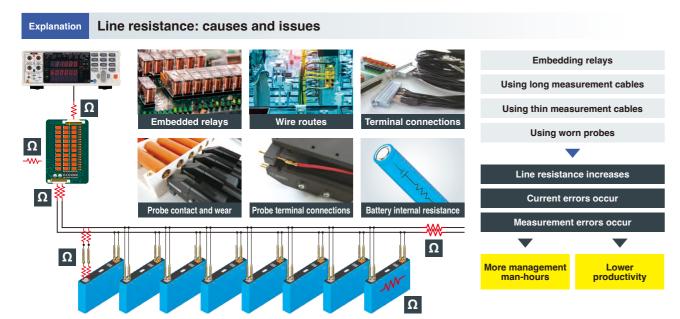
High line resistance can cause current errors and measurement errors, preventing accurate testing.

Constant-current errors

Flow of the measurement current is prevented, causing a constant-current error and making measurement impossible.

Measurement errors

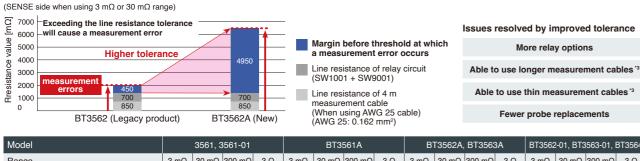
Stray capacitance between cables causes a leakage current through the line resistance, generating and voltage that causes a



Increasing line resistance tolerances

BT3561A, BT3562A, BT3563A

The new BT356xA has dramatically improved tolerances for line resistance compared to previous models. This improvement makes it easy to build test systems with large numbers of channels using relays. Additionally, a longer maintenance cycle for systems in use means fewer maintenance man-hours. Finally, its capability to handle thinner cables than with previous models and a second resistance.

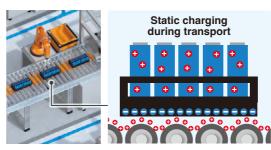


Model			3561, 3561-01			B13561A			B13562A, B13563A			B13562-01, B13563-01, B13564					
Range		3 mΩ	30 mΩ	300 mΩ	3 Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3 Ω	3 mΩ	30 mΩ	300 mΩ	3 Ω
Measurement current		N/A	N/A	10 mA	1 mA	N/A	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA
Allowable total line resistance	SENSE line	N/A	N/A	20 Ω	20 Ω	N/A	6.5 Ω	30 Ω	30 Ω	6.5 Ω	6.5 Ω	30 Ω	30 Ω	2Ω	2 Ω	15 Ω	15 Ω
(error detection) *1 *2	SOURCE line	N/A	N/A	50 Ω	500 Ω	N/A	5.5 Ω	15 Ω	150 Ω	5.5 Ω	5.5 Ω	15 Ω	150 Ω	2Ω	2 Ω	15 Ω	150 Ω

^{*1:} Typical value *2: Total line resistance = (Wiring resistance + Contact resistance + DUT resistance)

Preventing instrument malfunctions caused by static electricity

BT3561A, BT3562A, BT3563A





Batteries can become charged on production lines, for example, when being transported on a conveyor belt. When probes are placed in contact with such batteries, the resulting application of static electricity can then damage the instrument. The BT356xA series is designed to withstand contact with ±30 kV of static electricity*, preventing static-caused malfunctions and reducing testing line downtime.

* ±30 kV IEC 61000-4-2 contact discharge

LAN interface as standard

BT3561A, BT3562A, BT3563A



The BT356xA series is equipped with a LAN interface as standard equipment, making it easy for the instrument to interoperate with a PLC'2-based control system. The ability to use readily accessible LAN cables helps lower costs during system development and maintenance. Furthermore, a design with strong noise and static electricity resistance helps avoid system problems.

*1: Max.30 m

*2: Programmable Logic Controller,

a device that automatically controls one or more machines

Contact check

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560



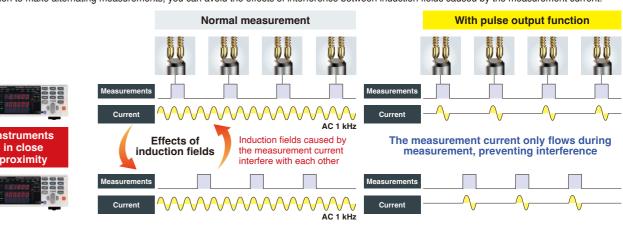


Accurate probing is essential for accurate measurement. Our battery testers are equipped with probe contact monitoring functionality to ensure highly reliable testing.

Using multiple instruments simultaneously

BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

When multiple battery testers are used at the same time, their induction fields can interfere with each other, causing measurement errors. Since the instruments' measurement currents flow continuously, such interference can occur even if measurements are timed so that they don't occur simultaneously. The measurement current pulse output function allows the measurement current to flow only during measurement. By using this function to make alternating measurements, you can avoid the effects of interference between induction fields caused by the measurement current.



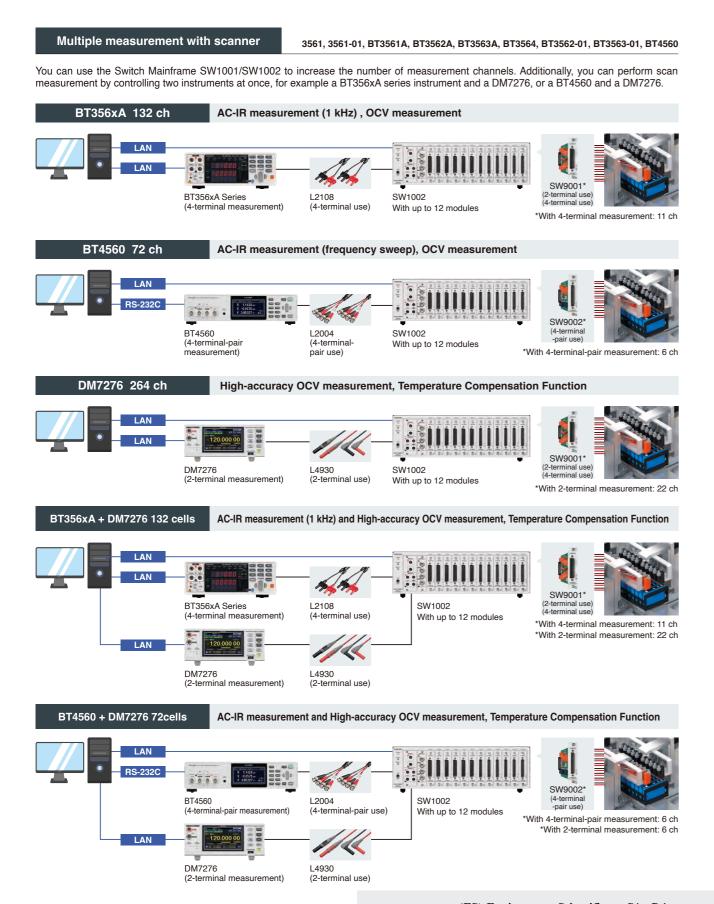
^{*3:} AWG 29 (0.064 mm²) wire equivalent to 2.2 Ω over an 8 m round trip can be used with the 3 m Ω or 30 m Ω range.

Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system

Improving productivity by reducing test times



Configuration Example of Multi-channel Battery Testing

Instrument	Number of instruments in use	AC-IR measurement 1 kHz	AC-IR measurement frequency sweep	OCV measurement	High-accuracy OCV measurement Temperature Compensation Function	Connection cable	Switch mainframe	Module	Maximum number of channels
BT356xA	1	YES	N/A	YES	N/A	L2108	SW1002	SW9001	132 ch
BT4560	1	YES	YES	YES	N/A	L2004	SW1002	SW9002	72 ch
DM7276	1	N/A	N/A	N/A	YES	L4930	SW1002	SW9001	264 ch
BT356xA	2	YES	N/A	YES	N/A	L2108	SW1002 Switching	SW9001	132 ch
DM7276	(switched)	N/A	N/A	N/A	YES	L4930	instrument	3009001	132 (11
BT4560	2	YES	YES	YES	N/A	L2004	SW1002 Switching	SW9002	72 ch
DM7276	(switched)	N/A	N/A	N/A	YES	L4930	instrument	3009002	72 CH







SW1002





SW9002 SW9001

SW1002: accomodates up to 12 SW9001 or SW9002 modules SW1001: accompdates up to 3 SW9001 or SW9002 modules

SW9001 (2-terminal use, 4-terminal use), SW9002 (4-terminal-pair use)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



MECH 25-hi TUR MEH-

Multichannel Nyquist or Cole-Cole plot (Interval setting: 1 second to 60 minutes)

Logging function

Measure and log up to 264 channels.

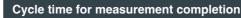
OCV measurement function

Measure OCVs, and additionally record the initial voltages and change rates as well.

Multichannel Nyquist or Cole-Cole plot

Measure impedance while varying the frequency across up to 72 channels and display the results as a Nyquist or Cole-Cole plot.

*PC application for SW1001/SW1002.



3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



Instrument	Module	Number of channels	Function	Measurement speed	Measurement response time	Total time	(All channels)	Conditions
BT3562A	SW9001	11	ΩV	EX. FAST	10 ms	0.45 s	Approx. 41 ms/ch	Communication with BT3562A
D13302A		11	220	MEDIUM	10 ms	1.1 s	Approx. 100 ms/ch	via RS-232C (38400 bps)
	SW9002	6		FAST	0 ms	1.0 s	ripproxition more in	Communication with BT4560 via USB (9600 bps) Measurement frequency: 1 kHz
BT4560		6	RX	MEDIUM	0 ms	1.2 s	Approx. 200 ms/ch	
		22		0.02 PLC*	0 ms	0.45 s	Approx. 20 ms/ch	Communication with
DM7276	SW9001	22	V	FAST	0 ms	0.85 s	Approx. 39 ms/ch	DM7276 via USB
		22		MEDIUM	0 ms	4.9 s	Approx. 223 ms/ch	Contact check: Off
								•

Internal resistance and open-circuit voltage for various battery types and compatible instruments



battery packs safely



voltage 1000 V The BT3564 can safely test high-voltage battery packs such as infrastructure storage batteries.



discharges, which are prone to occur during high-voltage measurement, by limiting the amount of current that flows the instant contact



The optional L2110 probe, which is designed specifically for use with the BT3564, can make measurements safely thanks to its 1000 V withstand voltage. Additionally, the probe is designed to accommodate battery packs whose terminals are placed far apart.

Diagnosing degradation in batteries

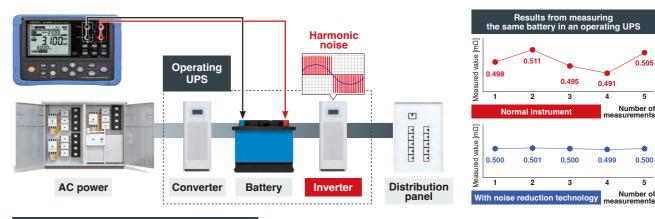
BT3554-50, BT3554-51, BT3554-52



Accurate measurement, even in a noisy environment

BT3554-50, BT3554-51, BT3554-52

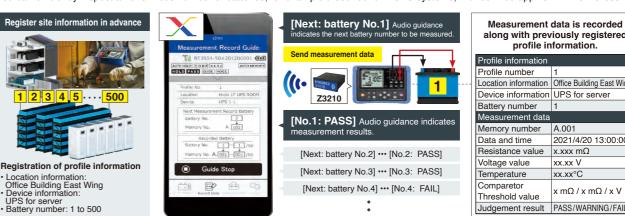
Inverters in operating UPS systems generate harmonic noise, and instruments usually have difficulties to make accurate measurements when affected by such noise. The BT3554-5x is able to measure accurately even when exposed to inverter noise thanks to its noise reduction technology.



Completing an intensive inspection workload efficiently

BT3554-50, BT3554-51, BT3554-52

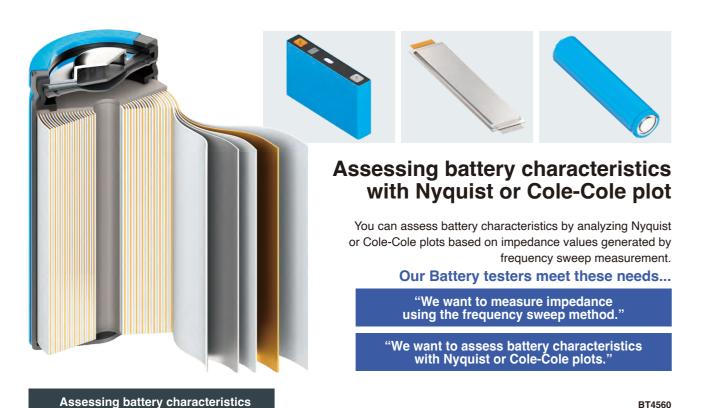
You can efficiently inspect an enormous number of batteries, for example those found in UPS systems, with our free app "GENNECT Cross"



along with previously registered profile information. ocation information Office Building East Wing Device information UPS for server Memory number A.001 2021/4/20 13:00:00 esistance value x.xxx mΩ xx.xx V xx.xx°C $x m\Omega / x m\Omega / x V$ Judgement result PASS/WARNING/FAIL

Up to 100 sets of profile information can be registered on the BT3554-5x. Up to 500 data sets can be saved for each profile. (The BT3554-5x can save up to 6,000 data sets.)

To use GENNECT Cross, you must install the Wireless Adapter Z3210 (sold separately) and the GENNECT Cross app on your device.



The chemical reactions in batteries involve several processes and each process has its own reaction speed. Therefore by sweeping the frequency and measuring the impedance the characteristics of each part can be evaluated separately.

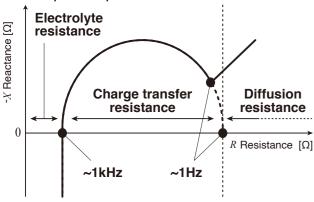
less than 1 Hz

hundred Hz

1 Hz to several Intermediate

frequencies

Drawing a Nyquist or Cole-Cole plot with an impedance spectrum

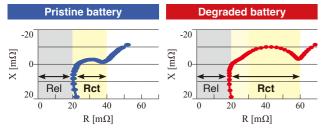


ı			\sim		Diagram of a discharging battery	Simple equivalent circu
		/ Charge		Diffusion	Load G	¬
	→	resist	ance	resistance	Anode Cathode	Double-layer capacitance
				R Resistance $[\Omega]$		Electrolyte resistance
		~1kHz	~1Hz			Charge Diffusion
					→ Diffusion resistance → Charge transfer resistance → Electrolyte resistance	transfer resistan resistance

Check the battery deterioration level

The resistance of a degraded battery is significantly larger than a pristine one. The degradation of charge transfer resistance is particularly noticeable in the Nyquist or Cole-Cole plot for applications that involve charging/discharging at low temperatures or deep charging/discharging (SOC between 0% and 100%).

Compare measured data for pristine and deteriorated batteries



Rel: Electrolyte resistance Rct: Reaction resistance

Idenfity battery deterioration factors

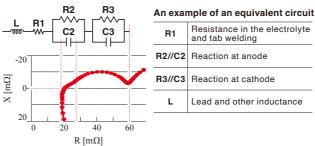
An equivalent circuit analysis software (e.g. ZView®*) can provide the parameters of each element of an equivalent circuit model by means of curve fitting. It allows you to see which part of the battery has shown characteristic changes. This serves to identify battery deterioration factors.

Li-ion diffusion in the electrode

(Charge transfer resistance)

Li-ion transport in electrolyte

(Diffusion resistance)



*ZView® is a product of Scribner Associates, Inc. For more information about ZView®, please contact Scribner Associates, Inc.

surement frequencies and

BT4560, IM3590

The BT4560 offers measurements in the optimal frequency range for liquid Li-ion batteries. Its unparalleled capability to measure extremely low impedance is ideal for large cells such as ones for xEVs or ESSs. As a complementary instrument, the IM3590 offers impedance measurements across a wider frequency range. It is very capable at measuring larger impedance.

Model		Measurement frequency			Max. Voltage	Impedance measurement ranges	
BT4560 (Standard specification)			0.1 Hz to 1050 Hz			5 V	3 mΩ, 10 mΩ, 100 mΩ
BT4560 (Special specifications for 20 V)			0.1 Hz to 1050 Hz			20 V	30 mΩ, 300 mΩ, 3 Ω
BT4560 (Special specifications for 10 mHz)		0.01	Hz to 1050 Hz			5 V	3 mΩ, 10 mΩ, 100 mΩ
BT4560 (Special specifications for 20 V, 10 mHz)		0.01	Hz to 1050 Hz			20 V	30 mΩ, 300 mΩ, 3 Ω
BT4560 (Special specifications for 10 kHz)		0.01	Hz to 10 kHz			5 V	3 mΩ, 10 mΩ, 100 mΩ
IM3590	1 mH	1 mHz to 200 kHz			5 V	100 mΩ to 100 MΩ	

BT4560 **BATTERY IMPEDANCE METER**

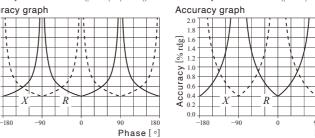
IM3590 CHEMICAL IMPEDANCE ANALYZER

In the case battery voltage is over 20 V, please contact distributors or sales branches.

BT4560 Accuracy specifications

Impedance measurement accuracy

-							
$3~m\Omega$ range (0.1 Hz to 100 Hz) $10~m\Omega$ range, $100~m\Omega$ range	$3~\text{m}\Omega$ range (110 Hz to 1050 Hz)						
$R ext{ accuracy } = \pm (0.004 \mid R \mid + 0.0017 \mid X \mid) [\text{m}\Omega] \ \pm \alpha$	$R \; {\rm accuracy} \; = \pm (0.004 \; \; R \; \; + \; 0.0052 \; \; X \; \;) \; [{\rm m}\Omega] \; \pm \alpha$						
$X {\rm accuracy} = \pm (0.004 X + 0.0017 R) [{\rm m}\Omega] \pm \alpha$	X accuracy = $\pm (0.004 \mid X \mid + 0.0052 \mid R \mid) [\text{m}\Omega] ~\pm \alpha$						
$Z \operatorname{accuracy} = \pm 0.4\% \operatorname{rdg} \pm \alpha \left(\sin \theta + \cos \theta \right)$	$Z \operatorname{accuracy} = \pm 0.4\% \operatorname{rdg} \pm \alpha \left(\sin \theta + \cos \theta \right)$						
θ accuracy = $\pm 0.1^{\circ} \pm 57.3 \frac{\alpha}{Z} (\sin \theta + \cos \theta)$	θ accuracy = $\pm 0.3^{\circ} \pm 57.3 \frac{\alpha}{z} (\sin \theta + \cos \theta)$						
Accuracy graph	Accuracy graph						
2.0	2.0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1						



Impedance accuracy excluding α (0.004 | R | + 0.0017 | X |, 0.004 | X | + 0.0017 | R |)

Impedance accuracy excluding α (0.004 | R | + 0.0052 | X |, 0.004 | X | + 0.0052 | R |)

The units of R and X are $[m\Omega]$, α is as shown below

Range		3 mΩ	10 mΩ	100 mΩ			
	FAST	25 dgt	60 dgt	60 dgt			
α	MED	15 dgt	30 dgt	30 dgt			
	SLOW	8 dgt	15 dgt	15 dgt			
Temperature		$R: \pm R$ accuracy \times 0.1 / °C, $X: \pm X$ accuracy \times 0.1 / °C, $Z: \pm Z$ accuracy \times 0.1 / °C,					
CO	°C and 28°C to 40 °C)						

Voltage measurement accuracy

V	Display range	$-5.10000 \ V$ to $5.10000 \ V$		
V	Resolution	10 μV		
Voltage accuracy	FAST/MED/SLOW	±0.0035% rdg ±5 dgt		
Temperature coefficient		gt / °C f 0°C to 18°C and 28°C to 40°C)		

Temperature measurement accuracy (BT4560 + Z2005 temperature sensor)

	, , , , , , , , , , , , , , , , , , , ,
Accuracy	±0.5°C (measurement temperature: 10.0°C to 40.0°C) ±1.0°C (measurement temperature: -10.0°C to 9.9°C, 40.1°C to 60.0°C)
Temperature	+0.01°C/°C

coefficient (applied in the ranges of 0°C to 18°C and 28°C to 40°C)

FACT MED CLOW

	LASI	IVIED	SLUW
0.10 Hz to 66 Hz	1 wave	2 waves	8 waves
67 Hz to 250 Hz	2 waves	8 waves	32 waves
260 Hz to 1050 Hz	8 waves	32 waves	128 waves

Measurement probes and specialized jigs

Cables are also available on a special-order basis Please contact HIOKI for more information

Convert the BT4560's 4-terminal-pair



L2000















For securing 1 cell'2'3 For securing up to 6 cells'2'3 With batteries attached Connection cord '2'3 (Accommodates 18650, 21700, 4680 and 26650 size cells.)

Test fixture for cylindrical batteries to use with the Pin Type Probe L2003

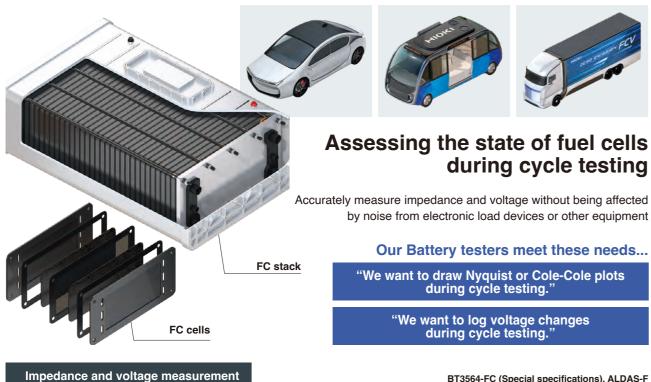
*1: See pages 22 and 23 for compatible probes

*2: Special-order product. *3: Used when combining the BT4560 with the SW1001/SW1002 and SW9002.

plug adapter

Analyzing fuel cells (FCs)

BT3564-FC (Special specifications), ALDAS-F



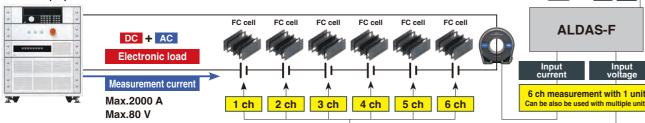
BT3564-FC (Special specifications), ALDAS-F

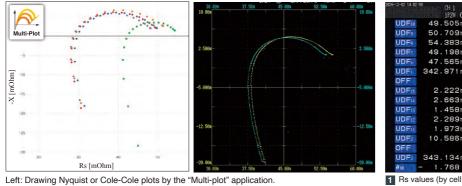
USB

Enable to draw Nyquist or Cole-Cole plots along with voltage measurement in an operating FC stack for each cells.

electronic load device

with AC superposition function





Right: Drawing Nyquist or Cole-Cole plots bt the ALD

-12.50a	UDF ₂ 1.973m0 UDF ₂ 10.586m0 OFF	1	0.0342 V]	8 items PLOT
8. 60m20 60m 38. 60m - 37. 50m - 45. 60m - 52. 50m - 68. 60m	UDF3 343.134m0 θω - 1.768 °	2.20	0.0000mAh	2 1000
ulti-plot" application.	1 Rs values (by cell a	,	Ripple current valu	
.DAS-F. (Plots can be displayed for up to two channels.)	2 -X values (by cell ar	nd overall)	priase arigie, and i	requency

Current sensor lineup

Model	BT3564-FC/BT3563-FC (Special specifications) (Not CE marked)	ALDAS-F			
Measurement frequency	1 kHz	0.01 Hz to 10 kHz			
Max. measurement voltage	1000 V (BT3564-FC)/300 V (BT3563-FC)	80 V			
Max. allowable input current	Not specified	2000 A			
Number of channels ⁻¹	1 ch	1 ch to 6 ch (× Number of units in use)			

^{*1:} The number of channels can be increased using the SW1001/SW1002. (Maximum allowable voltage: 60 V DC)

Appearance	Model	Rated current	Frequency characteristics	Core diameter
Pass-through	CT6877A	2000 A	DC to 1 MHz	ф80 mm
type	CT6876A	1000 A	DC to 1.5 MHz	ф36 mm
	CT6904A-2	800 A	DC to 4 MHz	ф32 mm
	CT6904A	500 A	DC to 4 MHz	ф36 mm
	CT6875A	500 A	DC to 2 MHz	ф36 mm
Clamp type	CT6846A	1000 A	DC to 100 kHz	ф50 mm
	CT6845A	500 A	DC to 200 kHz	ф50 mm
	CT6844A	500 A	DC to 500 kHz	ф20 mm
	CT6843A	200 A	DC to 700 kHz	ф20 mm
	CT6841A	20 A	DC to 2 MHz	Ф20 mm





Web application "Multi-plot"

Converting measurement data into a Nyquist or Cole-Cole plot

web browser link

https://www.circuitfitting.net/multiplot

"Multi-plot", a free web application, enables you to draw

a Nyquist or Cole-Cole plot simply by loading a file in your web browser.

Supported files: CSV file, ZView®* (.z) file

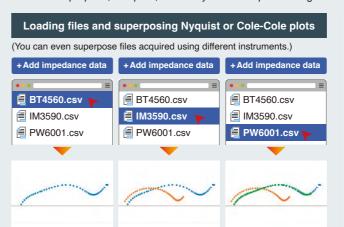
Supported instruments: BT4560, PW6001, IM3536, IM3570, IM3590, IM758x

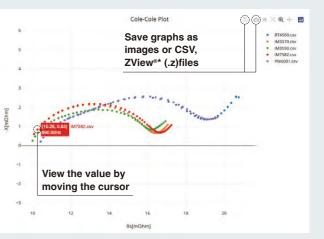


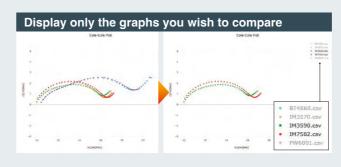


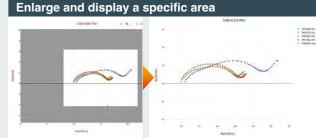


Draw Nyquist or Cole-Cole plots freely, without any limits on the number of points that can be rendered from files or the number of graphs that can be superposed. The horizontal and vertical axes are automatically scaled based on the graphs being rendered. You can even superpose, compare, and analyze files acquired using different instruments.









Analysis function

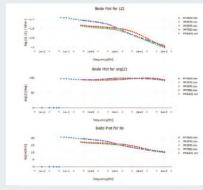
Conduct an equivalent circuit analysis

Nyquist or Cole-Cole plot Rs[mOhm] rmse_score[Ohm] : 6.93e-5 R0[Ohm] : 9.17e-3 L3[H] : 1.07e-7 R3[Ohm] : 1.00e+1 Model: R0-(L3//R3)-(CPE1//R1)-(CPE2//R2)-W1 L3 CPE1 CPE2 CPE1 Q[Ohm^-1 sec^p]: 3.25e+0 CPE1_p[]: 6.01e-1 R1[Ohm]: 7.57e-3

Analyze the data with predefined models.

simply by loading a file.

Draw Bode plots to assess phase characteristics



Display analysis results automatically assess phase characteristics.

Rotate the graph in 3D

Analyze characteristics with 3D view

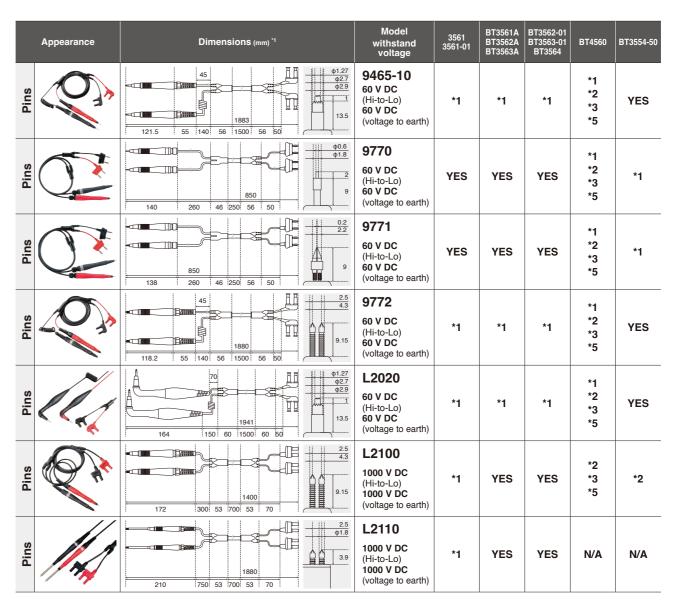
Bode plots are also drawn, enabling to Draw 3D Nyquist or Cole-Cole plots or 3D Bode plots, using the time or date as a third axis. Rotate 3D graphs in any direction as desired and save images.

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Measurement lead and measurement probe compatibility chart

YES	:	Recommended measurement lead or measurement probe listed in brochures.
N/A	:	Not compatible due to inability to connect.
*1	:	Not subject to accuracy guarantee.
*2	:	May be susceptible to external noise. Caution is particularly required when using a measurement current of 10 mA or less.
*3	:	BNC – banana plug adapter (See page 19) Connect the black banana plugs to the HCUR and HPOT terminals to reduce the influence from external noise.
*4	:	Temperature sensor cannot be connected.
*5	:	It does not use a 4-terminal-pair design, so wiring placement will have a greater effect on measured values.
*6		Some measurement ranges cannot be used due to rated current limitations

	Appearance	Dimensions (mm) *1	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
Clips	MA	1310 1310 1310 1310 1310 1310 1310 1310	9467 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	YES
Clips		220 106 300 56 1500 56 200	9460 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1 *4	*1 *4	*1 *4	*1 *2 *3 *5	YES
Clips		1000 85 188 35 630 62	±42 V peak AC+DC (Hi-to-Lo) ±42 V peak AC+DC (voltage to earth)	N/A	N/A	N/A	*6	N/A
Clips		1.6 5.2 1100 400 45 820 45 80	±30 V peak AC+DC (Hi-to-Lo) ±30 V peak AC+DC (voltage to earth)	N/A	N/A	N/A	YES	N/A
Pins		φ1.8 9.15 110 400 45 820 45 80	±30 V peak AC+DC (Hi-to-Lo) ±30 V peak AC+DC (voltage to earth)	N/A	N/A	N/A	YES	N/A
Clips		1100 84 130 745 85	L2107 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
Pins	19	1360 1300	9452 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	*1	*1	*1 *2 *3 *5	*1
Clips · Pins		280 1350 350 40 750 45 80	9453 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
Pins		00.24 0.12 135.5 260 56 250 56 70	9455 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	*1	*1	*1 *2 *3 *5 *6	*1
Pins		132.5 240 56 250 56 70	9461 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	*1



	Appearance	Dimensions (mm) 11	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
Clips	Way!	85 MAX 95 1500 84 250 955 70 73	L2101*2 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
Pins		85 \qu	L2102*2 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
Pins		1500 1500 885 70 73	L2103*2 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
Pins		280 1500 350 860 70 73	L2104*2 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2

Batteries are a driving force for a variety of innovations as we move towards a sustainable society

Batteries are used in an array of applications, and their performance can be a driving force for a variety of innovations and new lifestyles. The development and production of high-quality batteries will play an essential role as we work to realize a sustainable society. At the same time therefore, growing improvements in battery life cycle assessment have become a major priority. the focus on reducing CO2 emissions throughout the entire life cycle by means of improvements in manufacturing processes and reuse of high-quality batteries is increasing. HIOKI battery testers are helping resolve these issues through an electrical measurement approach.

Stacked battery voltage, Internal resistance of battery cells





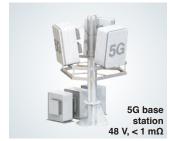






































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